

Nano-Current Power I_QSmart[™] Load Switch

Product Specification

DESCRIPTION

The GLF1110H / GLF1111H is an ultra-efficiency, 2 A rated, Load Switch with integrated slew rate control. The best in class efficiency makes it an ideal choice for use in IoT, mobile, and wearable electronics.

The GLF1110H / GLF1111H features ultra-efficient I_QSmart^{TM} technology that supports the lowest quiescent current (I_Q) and shutdown current (I_{SD}) in the industry. Low I_Q and I_{SD} solutions help designers to reduce parasitic leakage current, improve system efficiency, and increase battery lifetime.

The integrated slew rate control can also enhance system reliability by mitigating bus voltage swings during switching events. Where uncontrolled switches can generate high inrush currents that result in voltage droop and/or bus reset events, the GLF slew rate control specifically limits inrush currents during turn-on to minimize voltage droop.

The GLF1110H / GLF1111H supports an industry leading wide input voltage range and helps to improve operating life and system robustness. Furthermore, one device can be used in multiple voltage rail applications which helps to simplify inventory management and reduce operating cost.

FEATURES

• Wide Input Range: 1.5 V to 5.5 V

6 V abs max

• R_{ON}: 54 m Ω Typ at 5.5 V_{IN}

• I_{OUT} Max: 2 A

• Ultra-Low I_Q: 2 nA Typ at 5.5 V_{IN}

Ultra-Low I_{SD}: 13 nA Typ at 5.5 V_{IN}

 \bullet Controlled Rise Time: 600 μs at 3.3 V_{IN}

• Internal EN Pull-Down Resistor

 Integrated Output Discharge Switch: GLF1111H

Wide Operating Temperature Range:

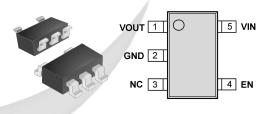
-40 °C ~ 105 °C

• HBM: 4 kV, CDM: 2 kV

APPLICATIONS

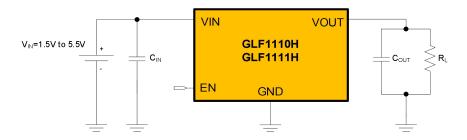
- Smart IoT Devices
- Portable Industrial Devices
- Low Power Subsystems

PACKAGE



SOT23-5L

APPLICATION DIAGRAM



GLF1110H, GLF1111H Nano-Current Power I_QSmart[™] Load Switch

ALTERNATE DEVICE OPTIONS

Part Number	Top Mark	R _{ON} (Typ) at 5.5 V	Output Discharge	EN Activity
GLF1110H-T1G7	DKH	54 mΩ	NA	High
GLF1111H-T1G7	DLH	54 mΩ	54 mΩ 85 Ω	

FUNCTIONAL BLOCK DIAGRAM

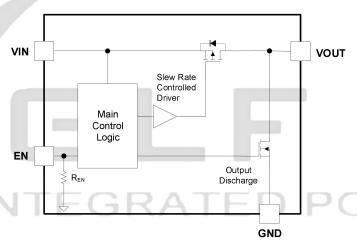


Figure 1. Functional Block Diagram

PIN CONFIGURATION

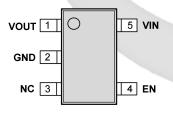


Figure 2. SOT23-5L

PIN DEFINITION

Pin#	Name	Description
1	VOUT	Switch Output
2	GND	Ground
3	NC	No connection
4	EN	Enable to control the switch
5	VIN	Switch Input. Supply Voltage for IC

ABSOLUTE MAXIMUM RATINGS

Stresses exceeding the absolute maximum ratings may damage the device. The device may not function or be operable above the recommended operating conditions; extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only.

Symbol	Par	Min.	Max.	Unit	
Vin	VIN, VOUT, VEN tO GND	-0.3	6	V	
I _{OUT}	Maximum Continuous Switch Current			2	Α
T _{STG}	Storage Junction Temperature	-65	150	°C	
θ _{JC}	Thermal Resistance, Junction to Case			90	°C/W
θ_{JA}	Thermal Resistance, Junction to Ambient			180	°C/W
ESD	Electrostatic Discharge Capability	Human Body Model, JESD22-A114	4		kV
ESD	Electrostatic Discharge Capability	Charged Device Model, JESD22-C101	2		KV

Note. The θ_{JA} is measured at T_A = 25°C on a high effective thermal conductivity four-layer test board per JEDEC 51-7.

RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter	Min.	Max.	Unit
V _{IN}	Supply Voltage	1.5	5.5	V
T _A	Ambient Operating Temperature	-40	+105	°C

ELECTRICAL CHARACTERISTICS

Values are at V_{IN} = 3.3 V and T_A = 25 °C unless otherwise noted.

Symbol	Parameter	Conditions		Min.	Тур.	Max.	Unit
Basic Ope	eration						•
1		V _{IN} = V _{EN} = 5.5 V, I _{OUT} = 0 mA	V _{IN} = V _{EN} = 5.5 V, I _{OUT} = 0 mA				
IQ	Quiescent Current (1)	$V_{IN} = V_{EN} = 5.5 \text{ V}, I_{OUT} = 0 \text{ mA}, T_A =$	85 °C ⁽⁴⁾		8.5		
		$V_{IN} = V_{EN} = 5.5 \text{ V}, I_{OUT} = 0 \text{ mA}, T_A =$	105 °C ⁽⁴⁾		20		
		$V_{EN} = 0 \text{ V}, V_{IN} = 1.5 \text{ V } I_{OUT} = 0 \text{ mA}$			2		
		$V_{EN} = 0 \text{ V}, V_{IN} = 3.3 \text{ V } I_{OUT} = 0 \text{ mA}$			3		nA
Isp	Chut Down Current	$V_{EN} = 0 \text{ V}, V_{IN} = 4.2 \text{ V } I_{OUT} = 0 \text{ mA}$		7	5		
ISD	Shut Down Current	$V_{EN} = 0 \text{ V}, V_{IN} = 5.5 \text{ V } I_{OUT} = 0 \text{ mA}$			13		
		$V_{EN} = 0 \text{ V}, V_{IN} = 5.5 \text{ V}, I_{OUT} = 0 \text{ mA},$		280			
		$V_{EN} = 0 \text{ V}, V_{IN} = 5.5 \text{ V}, I_{OUT} = 0 \text{ mA}, T_A = 105 °C (4)$			850		
		V _{IN} = 5.5 V, I _{OUT} = 500 mA	T _A = 25 °C		54		
	On-Resistance		T _A = 85 °C ⁽⁴⁾		63		
			T _A = 105 °C ⁽⁴⁾		68		
Ron			T _A = 25 °C		64		mΩ
		V _{IN} = 3.3 V, I _{OUT} = 500 mA	T _A = 85 °C ⁽⁴⁾		75		
			$T_A = 105 ^{\circ}C^{(4)}$		81		
		V _{IN} = 1.5 V, I _{OUT} = 100 mA	T _A = 25 °C		116		
R _{DSC}	Output Discharge Resistance	V _{EN} = Low , I _{FORCE} = 10 mA, GLF11	11H		85		Ω
V	EN Input Logic High	V _{IN} = 1.5 V to 1.8 V		0.9			V
V _{IH}	Voltage	V _{IN} = 1.8 V to 5.5 V	1.2			V	



GLF1110H, GLF1111H Nano-Current Power I_QSmart[™] Load Switch

\/	EN Input Logic Low	V _{IN} =1.5 V to 1.8 V		0.3	V
V_{IL}	Voltage	V _{IN} =1.8 V to 5.5 V		0.4	V
R _{EN}	EN pull down resistance	Internal Resistance	10		ΜΩ
I _{EN}	EN Current	V _{EN} = 5.5 V	0.5		μA
Switchin	g Characteristics ^(2, 3)				
t _{dON}	Turn-On Delay	D = 450 0 0 = 0.4 vF	450		
t _R	V _{OUT} Rise Time	R_L = 150 Ω, C_{OUT} = 0.1 μF	600		μs
t _{dOFF}	Turn-Off Delay (4)	D = 450 0 0 = 0.4 vF v Cl 54440H	17		
t _F	V _{OUT} Fall Time (4)	R_L = 150 Ω, C_{OUT} = 0.1 μF : GLF1110H	32		
t _{dOFF}	Turn-Off Delay (4)	D 450 0 0 0 0 4 vF v 0 1 54444 1 1	17		μs
t _F	V _{OUT} Fall Time (4)	R _L = 150 Ω, C _{OUT} = 0.1 μF : GLF1111H	12		1

Notes:

- 1. IQ does not include the enable pull down current (I_{EN}) through the pull-down resistor R_{EN}.
- ton = t_don + t_R, to_{FF} = t_do_{FF} + t_F
 Output discharge path is enabled during off.
- 4. By design; characterized, not production tested.

TIMING DIAGRAM

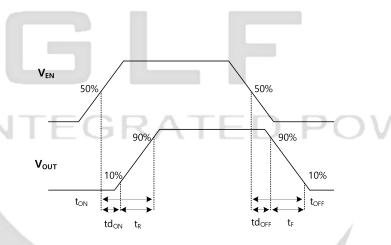


Figure 3. Timing Diagram

TYPICAL PERFORMANCE CHARACTERISTICS

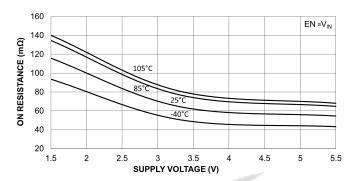


Figure 4. On-Resistance vs. Supply Voltage

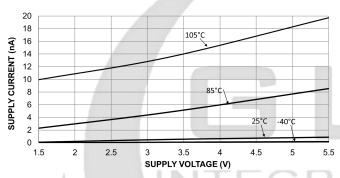


Figure 6. Quiescent Current vs. Supply Voltage

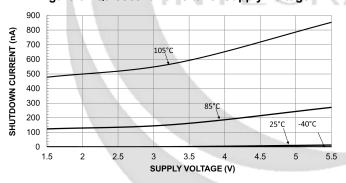


Figure 8. Shutdown Current vs. Input Voltage

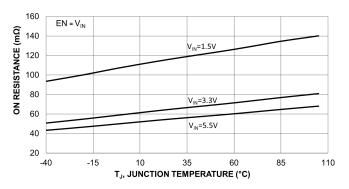


Figure 5. On-Resistance vs. Temperature

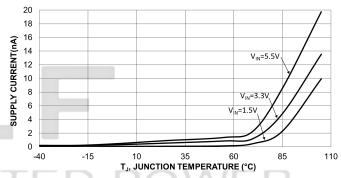


Figure 7. Quiescent Current vs. Temperature

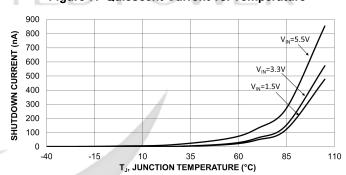


Figure 9. Shutdown Current vs. Temperature

Nano-Current Power I_QSmart[™] Load Switch

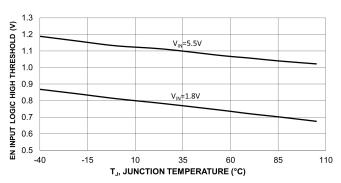


Figure 10. EN Input Logic High Threshold Vs. Temperature

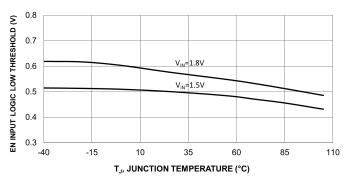


Figure 11. EN Input Logic Low Threshold Vs. Temperature

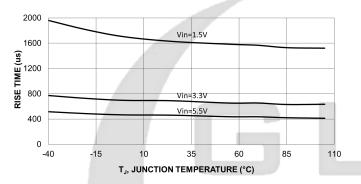


Figure 12. Vout Rise Time vs. Temperature

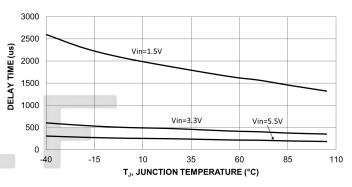


Figure 13. Turn-On Delay Time vs. Temperature

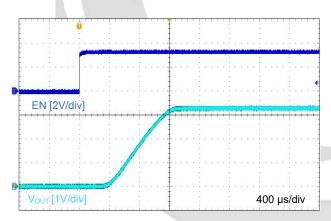


Figure 14. Turn-On Response, GLF1110H $V_{\text{IN}}{=}3.3~V,\,C_{\text{IN}}{=}0.1~\mu\text{F},\,C_{\text{OUT}}{=}0.1~\mu\text{F},\,R_{\text{L}}{=}150~\Omega$

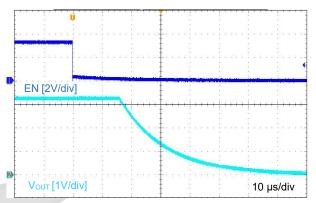


Figure 15. Turn-Off Response, GLF1110H V_{IN} =3.3 V, C_{IN} =0.1 μ F, C_{OUT} =0.1 μ F, R_L =150 Ω

Nano-Current Power IoSmart™ Load Switch

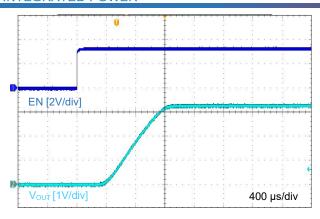


Figure 16. Turn-On Response, GLF1111H V_{IN} =3.3 V, C_{IN} =0.1 μ F, C_{OUT} =0.1 μ F, R_L =150 Ω

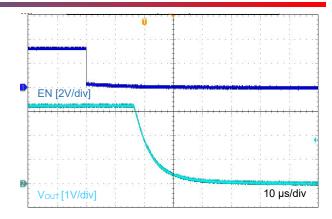


Figure 17. Turn-Off Response, GLF1111H V_{IN} =3.3 V, C_{IN} =0.1 μF , C_{OUT} =0.1 μF , R_L =150 Ω

APPLICATION INFORMATION

The GLF1110H / GLF1111H is an integrated 2 A, ultra-efficient I_QSmart[™] load switch devices with a fixed slew rate control to limit the inrush current during turn on. Each device is capable of operating over a wide input voltage range from 1.5 V to 5.5 V with very low on-resistance to reduce conduction loss. In the off state, these devices consume very low leakage current to avoid unwanted standby current and save limited input power. The 1110H / GLF1111H is characterized for operation in the temperature range from -40 °C to 105 °C.

Input and Output Capacitor

A minimum $0.1~\mu F$ input capacitor is recommended to be placed close to the V_{IN} pin to reduce the voltage drop on the input power rail caused by transient inrush current at start-up. A higher input capacitor value can be used to further attenuate the input voltage drop. Also, a minimum $0.1~\mu F$ output capacitor is recommended to minimize voltage undershoot on the output pin during the transition when the switch is turned off. Undershoot can be caused by parasitic inductance from board traces or intentional load inductances. If load inductances do exist, use of an output capacitor can improve output voltage stability and system reliability. The C_{OUT} capacitor should be placed close to the VOUT and GND pins.

EN pin

The GLF1110H / GLF1111H can be activated by forcing EN pin high level. Note that the EN pin has an internal pull-down resistor to help pull the main switch to a known "off state" when no EN signal is applied from an external controller.

Output Discharge Function

The GLF1111H has an internal discharge N-channel FET switch on the VOUT pin. When EN signal turns the main power FET to an off state, the N-channel switch turns on to discharge an output capacitor quickly.

Board Layout

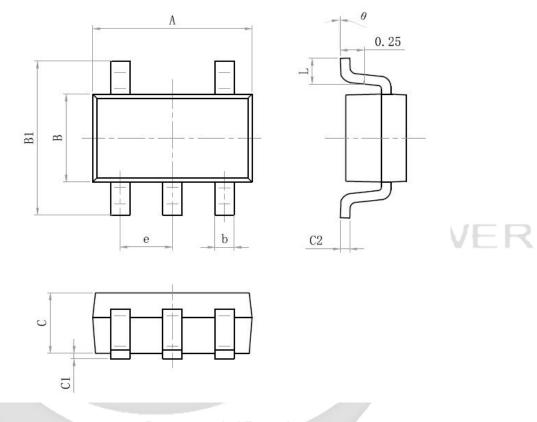
Rev 0.0 Nov 2023

All traces should be as short as possible to minimize parasitic inductance effects. Wide traces for VIN, VOUT, and GND will help reduce signal degradation and parasitic effects during dynamic operation as well as improve the thermal performance at high load current.

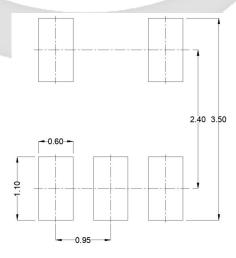


PACKAGE OUTLINE

Size Mark	Min(mm)	Max(mm)	Size Mark	Min(mm)	Max(mm)
A	2.82	3.02	С	1.05	1.15
е	0.9	95 (BSC)	C1	0.03	0. 15
b	0.28	0.45	C2	0.12	0.23
В	1.50	1.70	L	0.35	0. 55
B1	2, 60	3, 00	θ	0°	8°



Recommended Footprint

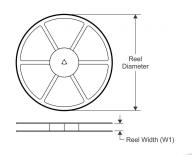


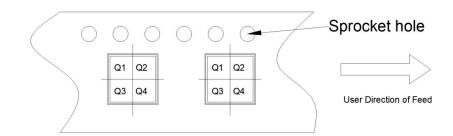
GLF1110H, GLF1111H Nano-Current Power I_QSmart™ Load Switch

TAPE AND REEL INFORMATION

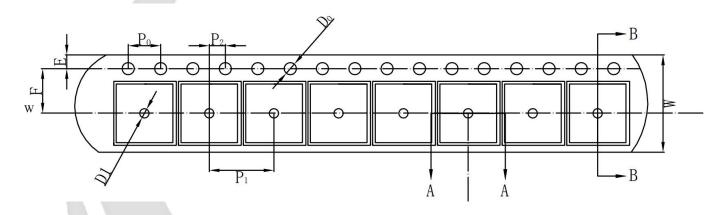
REEL DIMENSIONS

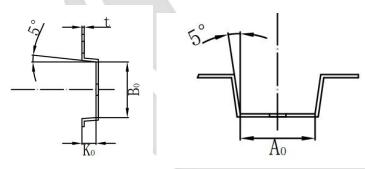
QUADRANT ASSIGNMENTS PIN 1 ORIENTATION TAPE





TAPE DIMENSIONS





Device	Package	Pins	SPQ	Reel Diameter (mm)	Reel Width W1	A0	В0	K0	P1	w	Pin1
GLF1110H-T1G7	SOT23-5	5	3000	178	9	3.25	3.30	1.38	4	8	Q3
GLF1111H-T1G7	SOT23-5	5	3000	178	9	3.25	3.30	1.38	4	8	Q3

- A0: Dimension designed to accommodate the component width
- B0: Dimension designed to accommodate the component length
- C0: Dimension designed to accommodate the component thickness
- W: Overall width of the carrier tape
- P1: Pitch between successive cavity centers

Nano-Current Power loSmart™ Load Switch

SPECIFICATION DEFINITIONS

Document Type	Meaning	Product Status
Target Specification	This is a target specification intended to support exploration and discussion of critical needs for a proposed or target device. Spec limits including typical, minimum, and maximum values are desired, or target, limits. GLF reserves the right to change limits at any time without warning or notification. A target specification in no way guarantees future production of the device in question.	Design / Development
Preliminary Specification	This is a draft version of a product specification. The specification is still under internal review and subject to change. GLF reserves the right to change the specification at any time without warning or notification. A preliminary specification in no way guarantees future production of the device in question.	Qualification
Product Specification	This document represents the anticipated production performance characteristics of the device.	Production

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